

MAC97 Series

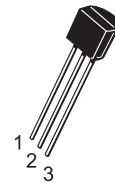
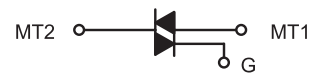
Preferred Device

Sensitive Gate Triacs Silicon Bidirectional Thyristors

Designed for use in solid state relays, MPU interface, TTL logic and any other light industrial or consumer application. Supplied in an inexpensive TO-92 package which is readily adaptable for use in automatic insertion equipment.

- One-piece, Injection-Molded Package
- Blocking Voltage to 600 Volts
- Sensitive Gate Triggering in Four Trigger Modes (Quadrants) for all possible Combinations of Trigger Sources, and especially for Circuits that Source Gate Drives
- All Diffused and Glassivated Junctions for Maximum Uniformity of Parameters and Reliability
- Device Marking: Device Type, e.g., MAC97A4, Date Code

TRIACS
0.8 AMPERE RMS
200 thru 600 VOLTS



MAXIMUM RATINGS ($T_J = 25^\circ\text{C}$ unless otherwise noted)

Rating	Symbol	Value	Unit
Peak Repetitive Off-State Voltage ($T_J = -40$ to $+100^\circ\text{C}$) (Note 1) Sine Wave 50 to 60 Hz, Gate Open MAC97A4 MAC97A6 MAC97-8, MAC97A8	V_{DRM} , V_{RRM}	200 400 600	Volts
On-State RMS Current Full Cycle Sine Wave 50 to 60 Hz ($T_C = +50^\circ\text{C}$)	$I_{T(RMS)}$	0.6	Amp
Peak Non-Repetitive Surge Current One Full Cycle, Sine Wave 60 Hz ($T_C = 110^\circ\text{C}$)	I_{TSM}	8.0	Amps
Circuit Fusing Considerations ($t = 8.3$ ms)	I^2t	0.26	A^2s
Peak Gate Voltage ($t \leq 2.0$ s, $T_C = +80^\circ\text{C}$)	V_{GM}	5.0	Volts
Peak Gate Power ($t \leq 2.0$ s, $T_C = +80^\circ\text{C}$)	P_{GM}	5.0	Watts
Average Gate Power ($T_C = 80^\circ\text{C}$, $t \leq 8.3$ ms)	$P_{G(AV)}$	0.1	Watt
Peak Gate Current ($t \leq 2.0$ μs , $T_C = +80^\circ\text{C}$)	I_{GM}	1.0	Amp
Operating Junction Temperature Range	T_J	-40 to + 100	$^\circ\text{C}$
Storage Temperature Range	T_{stg}	-40 to + 150	$^\circ\text{C}$

TO-92(TO-226AA)
CASE 029
STYLE 12

PIN ASSIGNMENT	
1	Main Terminal 1
2	Gate
3	Main Terminal 2

ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 8 of this data sheet.

Preferred devices are recommended choices for future use and best overall value.

1. V_{DRM} and V_{RRM} for all types can be applied on a continuous basis. Blocking voltages shall not be tested with a constant current source such that the voltage ratings of the devices are exceeded.

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THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Thermal Resistance, Junction to Case	$R_{\theta JC}$	75	$^{\circ}C/W$
Thermal Resistance, Junction to Ambient	$R_{\theta JA}$	200	$^{\circ}C/W$
Maximum Lead Temperature for Soldering Purposes for 10 Seconds	T_L	260	$^{\circ}C$

ELECTRICAL CHARACTERISTICS

($T_C = 25^{\circ}C$ unless otherwise noted; Electricals apply in both directions)

Characteristic	Symbol	Min	Typ	Max	Unit
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OFF CHARACTERISTICS

Peak Repetitive Blocking Current ($V_D = \text{Rated } V_{DRM}, V_{RRM}$; Gate Open)	I_{DRM}, I_{RRM}	—	—	10	μA
		—	—	100	μA

$T_J = 25^{\circ}C$
 $T_J = +110^{\circ}C$

ON CHARACTERISTICS

Peak On-State Voltage ($I_{TM} = \pm .85$ A Peak; Pulse Width ≤ 2.0 ms, Duty Cycle $\leq 2.0\%$)	V_{TM}	—	—	1.9	Volts
Gate Trigger Current (Continuous dc) ($V_D = 12$ Vdc, $R_L = 100$ Ohms)	I_{GT}	—	—	10	mA
MAC97-8 Device		—	—	10	
MT2(+),G(+)		—	—	10	
MT2(+),G(-)		—	—	10	
MT2(-),G(-)		—	—	10	
MT2(-),G(+)		—	—	10	
MAC97A4,A6,A8 Devices		—	—	5.0	
MT2(+), G(+)		—	—	5.0	
MT2(+),G(-)		—	—	5.0	
MT2(-),G(-)		—	—	5.0	
MT2(-),G(+)		—	—	7.0	
Gate Trigger Voltage (Continuous dc) ($V_D = 12$ Vdc, $R_L = 100$ Ohms)	V_{GT}	—	—	—	Volts
MT2(+), G(+) All Types		—	.66	2.0	
MT2(+),G(-) All Types		—	.77	2.0	
MT2(-),G(-) All Types		—	.84	2.0	
MT2(-),G(+) All Types		—	.88	2.5	
Gate Non-Trigger Voltage ($V_D = 12$ V, $R_L = 100$ Ohms, $T_J = 110^{\circ}C$) All Four Quadrants	V_{GD}	0.1	—	—	Volts
Holding Current ($V_D = 12$ Vdc, Initiating Current = 200 mA, Gate Open)	I_H	—	1.5	10	mA
Turn-On Time ($V_D = \text{Rated } V_{DRM}, I_{TM} = 1.0$ A pk, $I_G = 25$ mA)	t_{gt}	—	2.0	—	μs

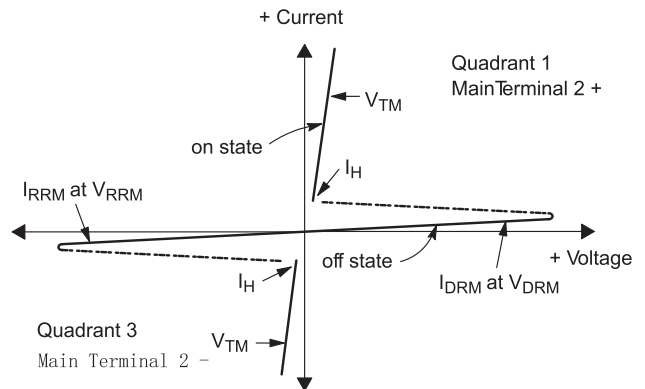
DYNAMIC CHARACTERISTICS

Critical Rate-of-Rise of Commutation Voltage ($V_D = \text{Rated } V_{DRM}, I_{TM} = .84$ A, Commutating $di/dt = .3$ A/ms, Gate Unenergized, $T_C = 50^{\circ}C$)	$dV/dt(c)$	—	5.0	—	$V/\mu s$
Critical Rate of Off-State voltage ($V_D = \text{Rated } V_{DRM}, T_C = 110^{\circ}C$, Gate Open, Exponential Waveform)	dv/dt	—	25	—	$V/\mu s$

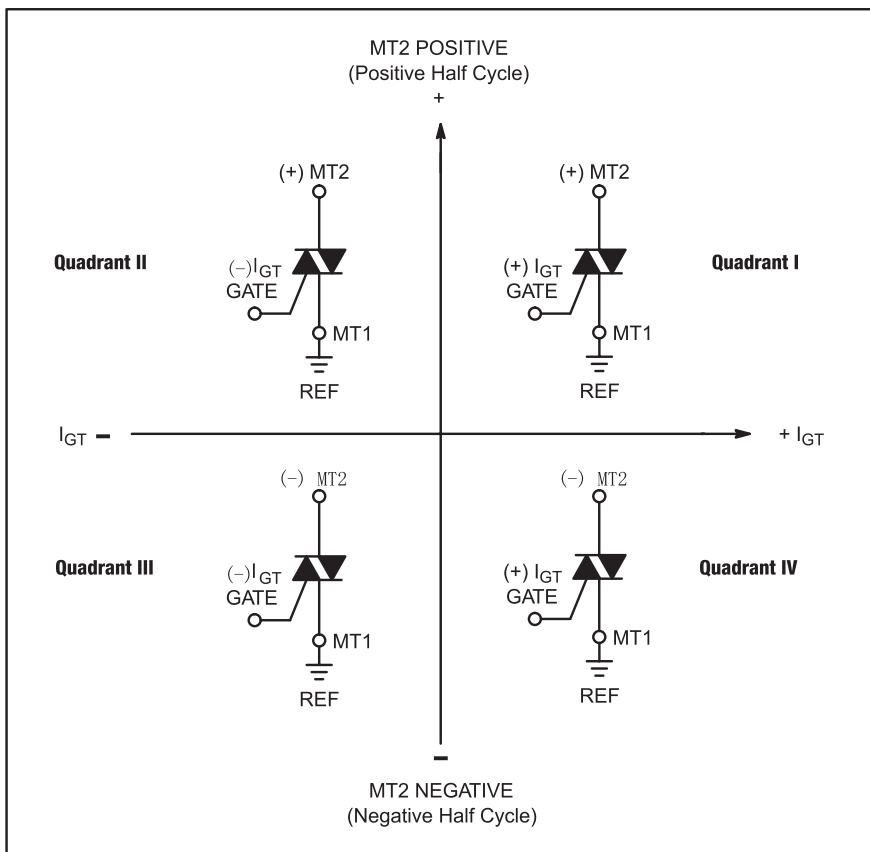
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Voltage Current Characteristic of Triacs (Bidirectional Device)

Symbol	Parameter
V_{DRM}	Peak Repetitive Forward Off State Voltage
I_{DRM}	Peak Forward Blocking Current
V_{RRM}	Peak Repetitive Reverse Off State Voltage
I_{RRM}	Peak Reverse Blocking Current
V_{TM}	Maximum On State Voltage
I_H	Holding Current



Quadrant Definitions for a Triac



All polarities are referenced to MT1.

With in-phase signals (using standard AC lines) quadrants I and III are used

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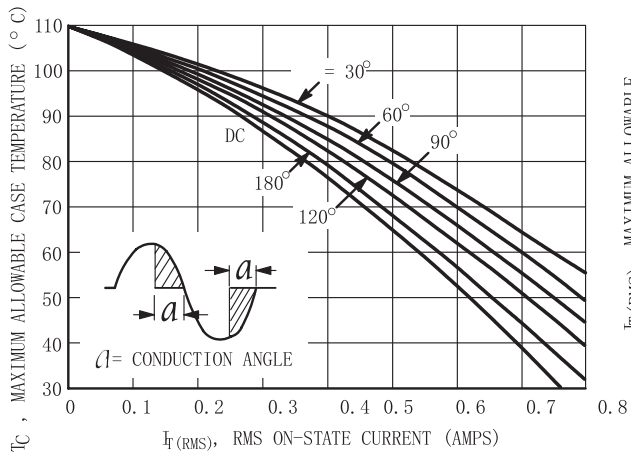


Figure 1. RMS Current Derating

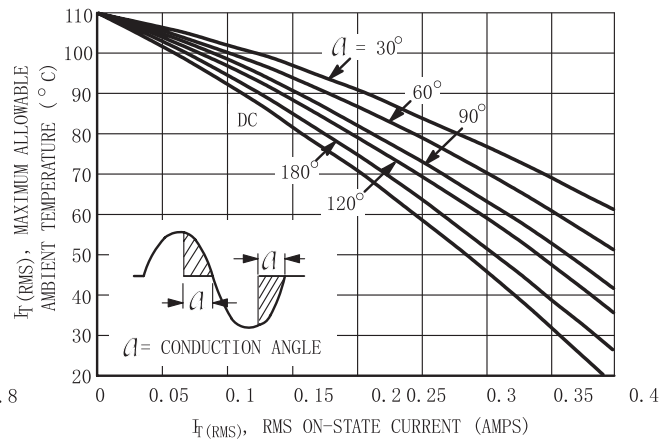


Figure 2. RMS Current Derating

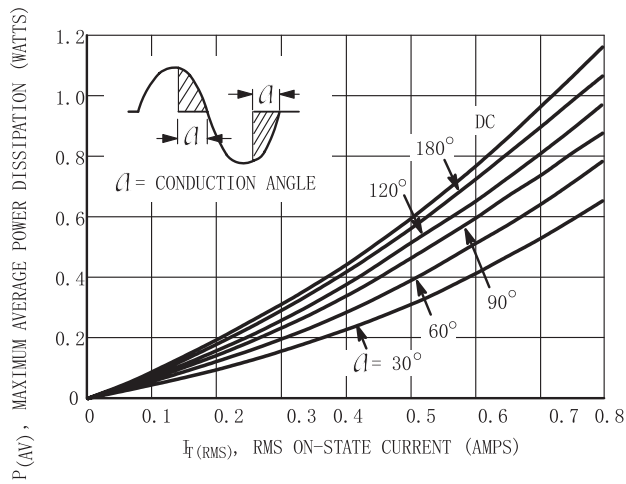


Figure 3. Power Dissipation

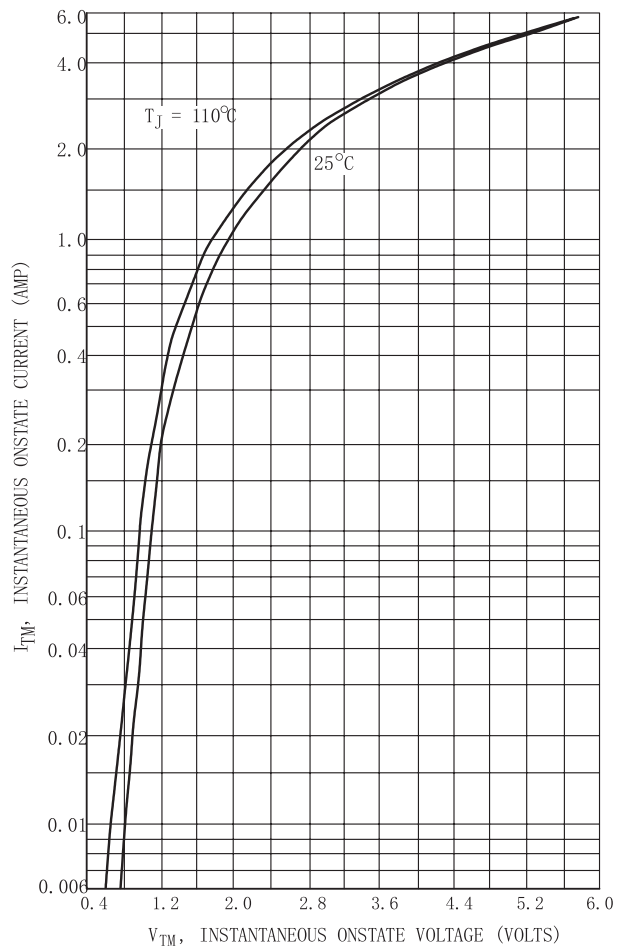


Figure 4. On-State Characteristics

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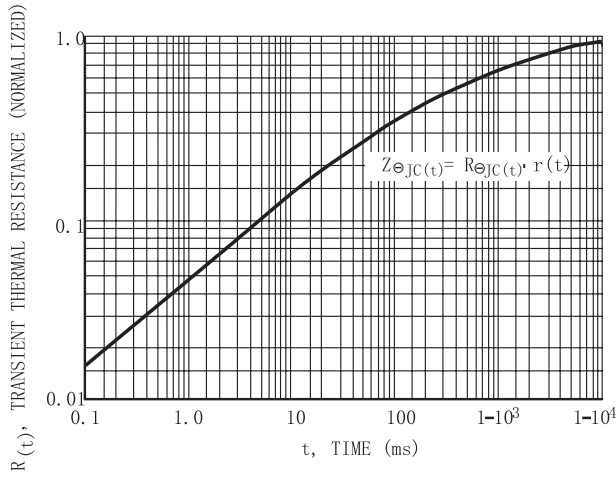


Figure 5. Transient Thermal Response

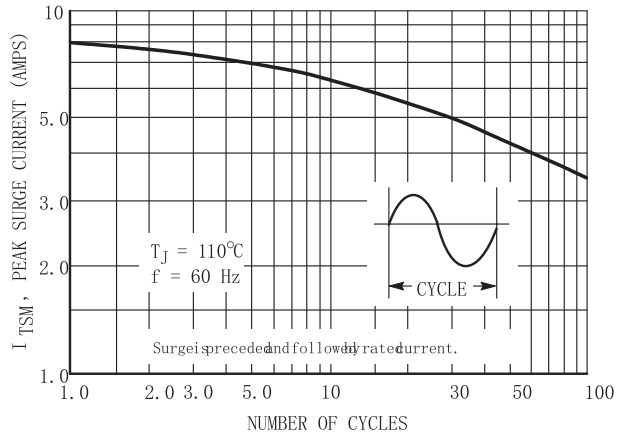


Figure 6. Maximum Allowable Surge Current

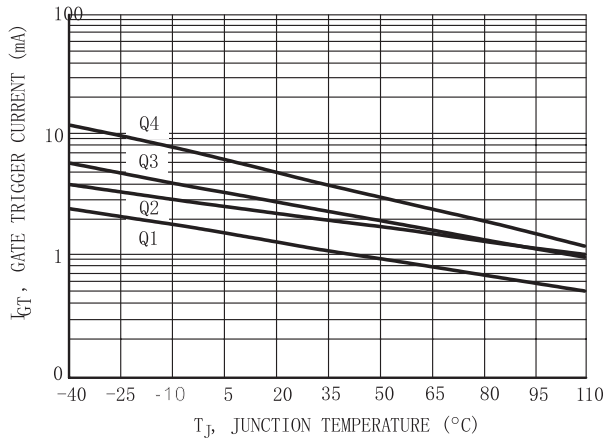


Figure 7. Typical Gate Trigger Current versus Junction Temperature

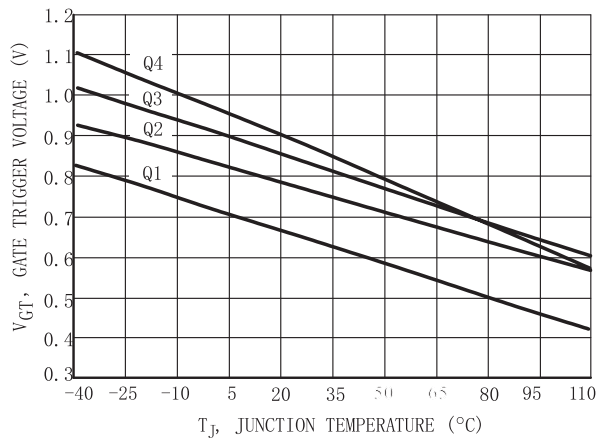


Figure 8. Typical Gate Trigger Voltage versus Junction Temperature

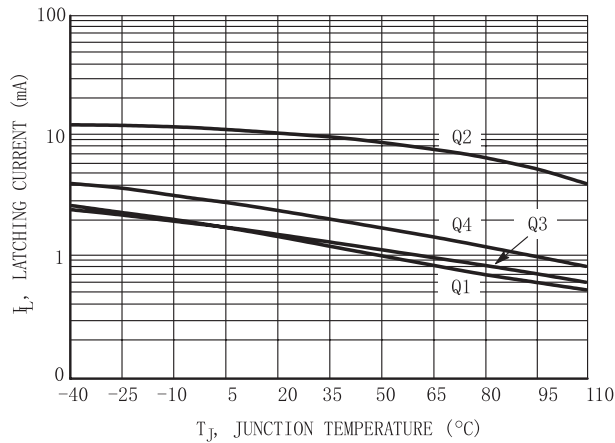


Figure 9. Typical Latching Current versus Junction Temperature

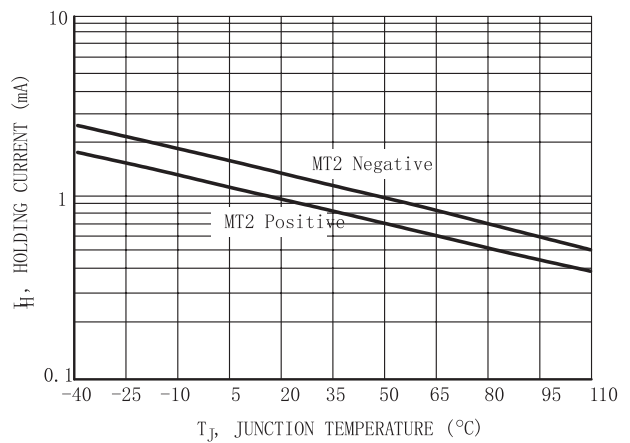
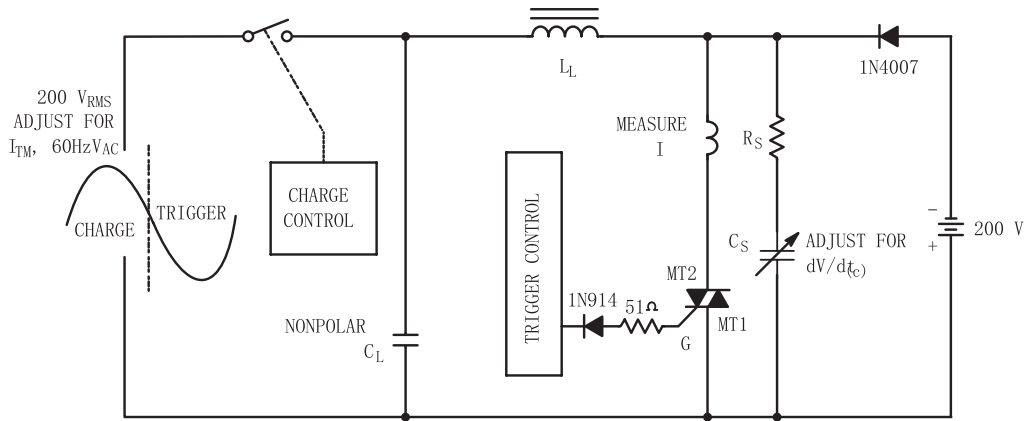


Figure 10. Typical Holding Current versus Junction Temperature

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Note: Component values are for verification of rated $(dv/dt)_c$. See AN1048 for additional information.

Figure 11. Simplified Test Circuit to Measure the Critical Rate of Rise of Commutating Voltage $(dv/dt)_c$